

Search Notes

Application/Control No.

10/802,046

Examiner

Christopher W. Fulton

Applicant(s)/Patent under
Reexamination

IKEDA ET AL.

Art Unit

2859

SEARCHED

Class	Subclass	Date	Examiner
399	254 359 358 255	6/23/2005	CWF

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Ex. Sophia Chen in class 399	6/23/2005	CWF